

TOSHIBA Multi Chip Discrete Device

HN4G01J

Audio Frequency General Purpose Amplifier Applications

Unit: mm

Q1

- Small package (Dual type)
- High voltage and high current
: $V_{CEO} = 50V$, $I_C = 150mA$ (max)
- High h_{FE} : $h_{FE} = 120 \sim 400$
- Excellent h_{FE} linearity
: $h_{FE}(I_C = 0.1mA) / h_{FE}(I_C = 2mA) = 0.95$ (typ.)

Q2

- Incorporating a bias resistor into a transistor reduces parts count.
Reducing the parts count enable the manufacture of ever more compact equipment and save assembly cost.

Q1 : 2SC4837F

Q2 : RN1103F

Q1 Absolute Maximum Ratings ($T_a = 25^\circ C$)

| Characteristic | Symbol | Rating | Unit |
|---------------------------|-----------|--------|------|
| Collector-base voltage | V_{CBO} | 60 | V |
| Collector-emitter voltage | V_{CEO} | 50 | V |
| Emitter-base voltage | V_{EBO} | 5 | V |
| Collector current | I_C | 150 | mA |
| Base current | I_B | 30 | mA |

Q2 Absolute Maximum Ratings ($T_a = 25^\circ C$)

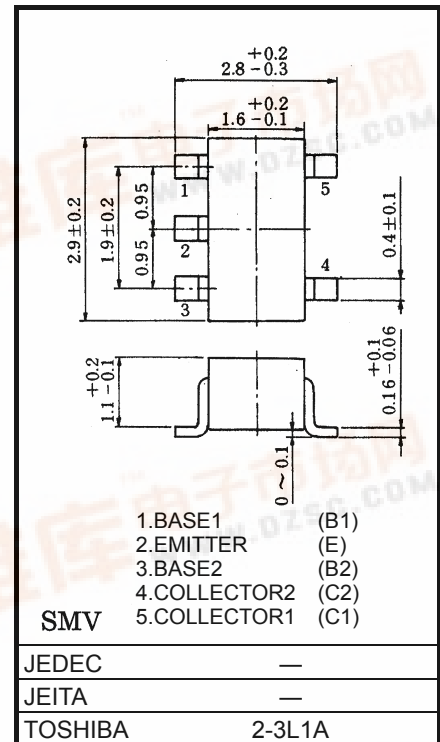
| Characteristic | Symbol | Rating | Unit |
|---------------------------|-----------|--------|------|
| Collector-base voltage | V_{CBO} | 50 | V |
| Collector-emitter voltage | V_{CEO} | 50 | V |
| Emitter-base voltage | V_{EBO} | 10 | V |
| Collector current | I_C | 100 | mA |

Absolute Maximum Ratings ($T_a = 25^\circ C$) (Q1,Q2Common)

| Characteristic | Symbol | Rating | Unit |
|-----------------------------|-----------|---------|------------|
| Collector power dissipation | P_C^* | 300 | mW |
| Junction temperature | T_j | 150 | $^\circ C$ |
| Storage temperature range | T_{stg} | -55~150 | $^\circ C$ |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



Weight: 0.014g(Typ.)

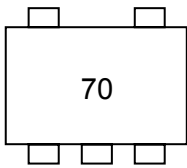
Electrical Characteristics (Ta = 25°C) (Q1)

| Characteristics | Symbol | Test Condition | Min | Typ. | Max | Unit |
|--------------------------------------|---------------|---|-----|------|------|---------------|
| Collector cut-off current | I_{CBO} | $V_{CB} = 60\text{ V}, I_E = 0$ | — | — | 0.1 | μA |
| Emitter cut-off current | I_{EBO} | $V_{EB} = 5\text{ V}, I_C = 0$ | — | — | 0.1 | μA |
| DC current gain | h_{FE} | $V_{CE} = 6\text{ V}, I_C = 2\text{ mA}$ | 120 | — | 400 | |
| Collector-emitter saturation voltage | $V_{CE(sat)}$ | $I_C = 100\text{ mA}, I_B = 10\text{ mA}$ | — | 0.1 | 0.25 | V |
| Transition frequency | f_T | $V_{CE} = 10\text{ V}, I_C = 1\text{ mA}$ | 60 | — | — | MHz |
| Collector output capacitance | C_{ob} | $V_{CB} = 10\text{ V}, I_E = 0, f = 1\text{ MHz}$ | — | 2.0 | — | pF |

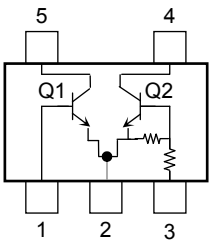
Electrical Characteristics (Ta = 25°C) (Q2)

| Characteristics | Symbol | Test Condition | Min | Typ. | Max | Unit |
|--------------------------------------|---------------|---|------|------|------|-----------|
| Collector cut-off current | I_{CBO} | $V_{CB} = 50\text{ V}, I_E = 0$ | — | — | 100 | nA |
| | I_{CEO} | $V_{CE} = 50\text{ V}, I_B = 0$ | — | — | 500 | |
| Emitter cut-off current | I_{EBO} | $V_{EB} = 10\text{ V}, I_C = 0$ | 0.17 | — | 0.33 | mA |
| DC current gain | h_{FE} | $V_{CE} = 5\text{ V}, I_C = 10\text{ mA}$ | 120 | — | — | |
| Collector-emitter saturation voltage | $V_{CE(sat)}$ | $I_C = 5\text{ mA}, I_B = 0.25\text{ mA}$ | — | 0.1 | 0.3 | V |
| Input voltage (ON) | $V_{I(ON)}$ | $V_{CE} = 0.2\text{ V}, I_C = 5\text{ mA}$ | 1.3 | — | 3.0 | V |
| Input voltage (OFF) | $V_{I(OFF)}$ | $V_{CE} = 5\text{ V}, I_C = 0.1\text{ mA}$ | 1.0 | — | 1.5 | V |
| Transition frequency | f_T | $V_{CE} = 10\text{ V}, I_C = 5\text{ mA}$ | — | 250 | — | MHz |
| Collector output capacitance | C_{ob} | $V_{CB} = 10\text{ V}, I_E = 0, f = 1\text{ MHz}$ | — | 3 | — | pF |
| Input resistor | R_1 | — | 15.4 | 22 | 28.6 | $k\Omega$ |
| Resistor ratio | R_1/R_2 | — | 0.9 | 1.0 | 1.1 | |

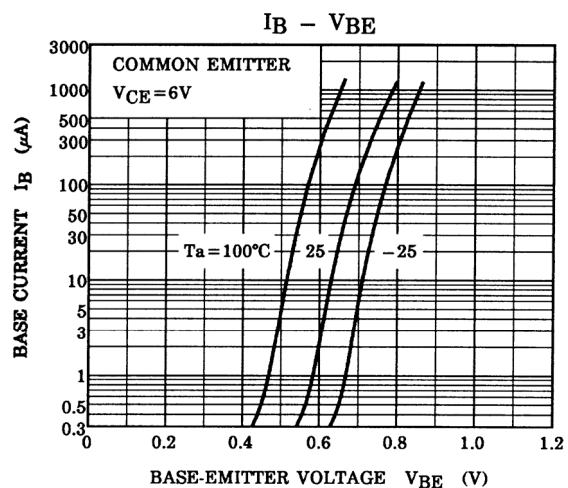
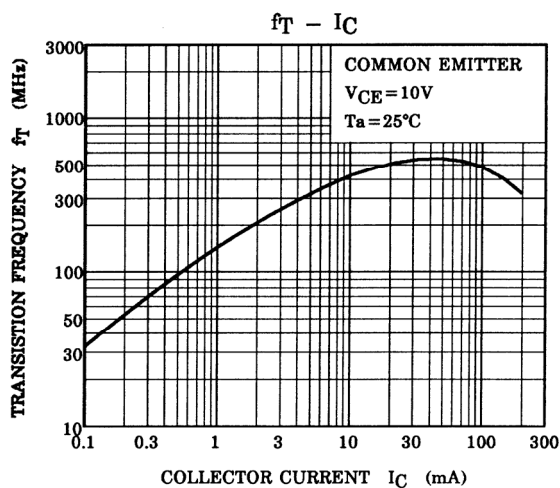
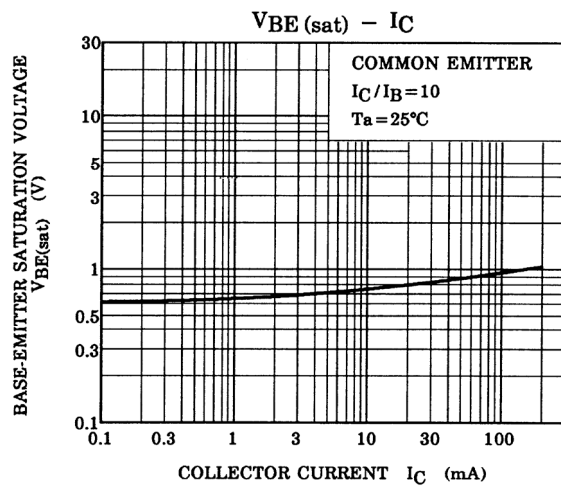
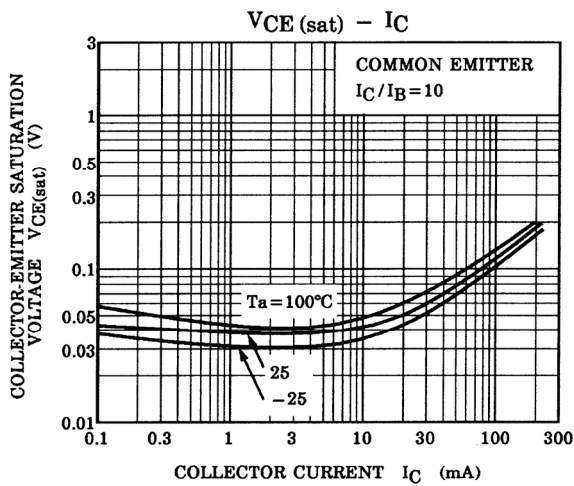
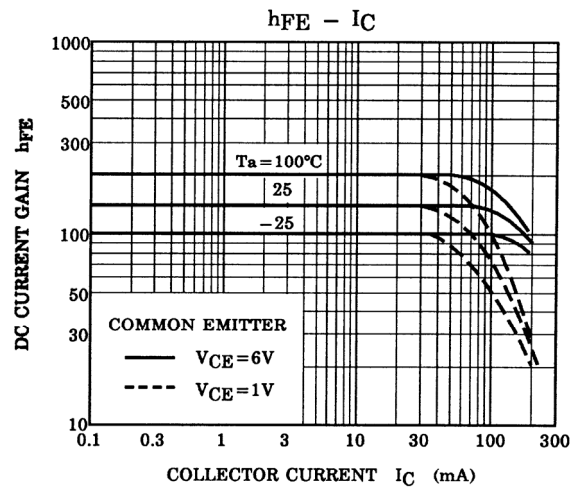
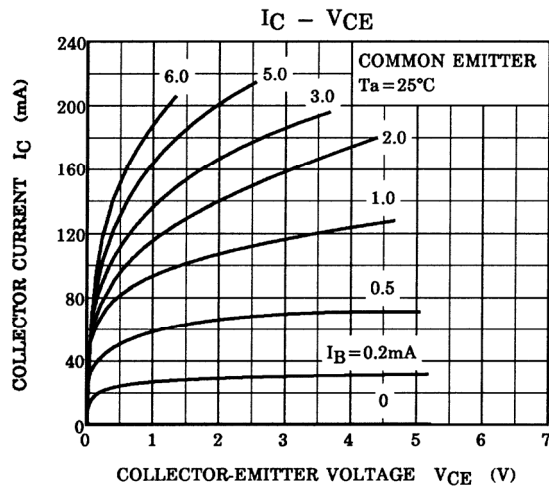
Marking



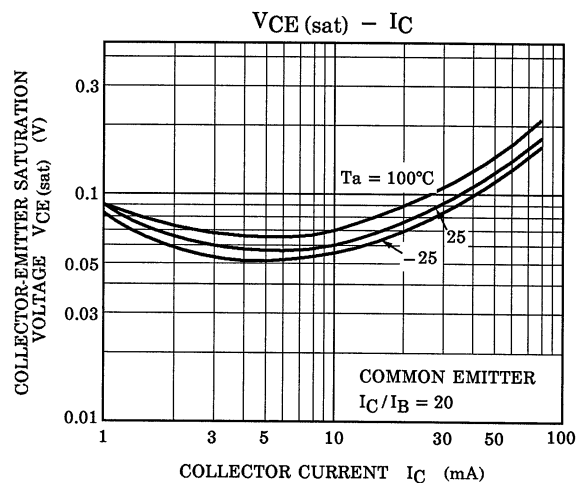
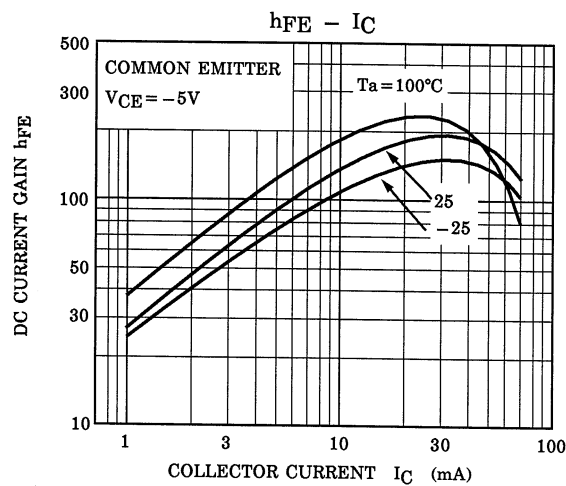
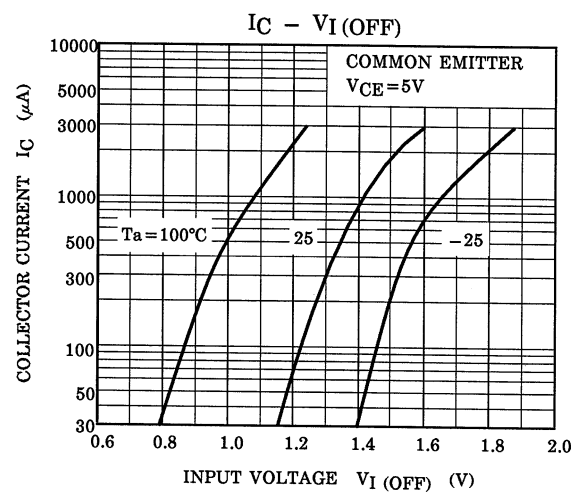
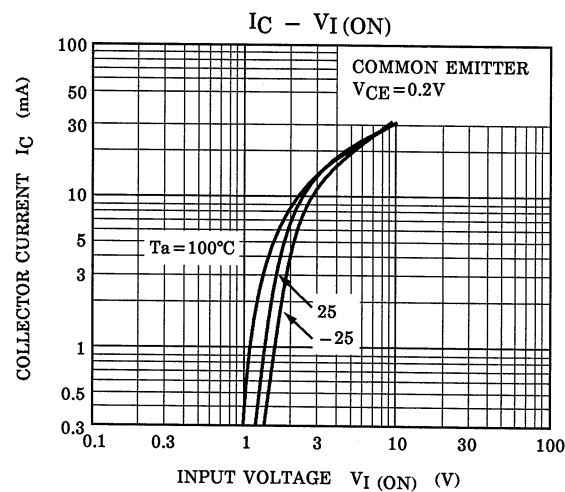
Equivalent Circuit (top view)



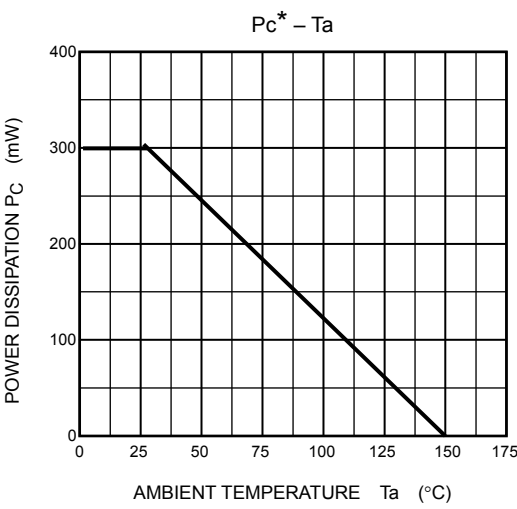
Q1



Q2



Q1,Q2 Common



*:Total Rating

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20070701-EN GENERAL

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